Notice of References Cited Application/Control No. | Applicant(s)/Patent Under | Reexamination | CHUNG ET AL. | Examiner | Art Unit | Alexander Markoff | 1746 | Page 1 of 1

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|---|-----------------|---------------------|----------------|
| * | Α | US-6,039,815 | 03-2000 | Yeol et al. | 134/2 |
| * | В | US-2002/0029788 | 03-2002 | Verhaverbeke et al. | 134/1.3 |
| * | С | US-2002/0032657 | 03-2002 | Singh, Kunwar C. | 705/44 |
| * | D | US-2002/0069895 | 06-2002 | Struven, Kenneth C. | 134/1.3 |
| * | E | US-2002/0144709 | 10-2002 | Kashkoush et al. | 134/1.3 |
| | F | US- | - | | |
| | G | US- | | | |
| | Н | US- | | | |
| | 1 | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | М | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
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| | 0 | | | | | |
| | Р | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | • | | |
| | Т | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | w | |
| | x | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.